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| Notice of References Cited | Application/Control No. 10/735,368 | Applicant(s)/Patent Under Reexamination ALDRICH ET AL. | |
| | Examiner Shelby Fidler | Art Unit 2861 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| | A | US-6,554,392 B2 | 04-2003 | Vega et al. | 347/23 |
| | B | US-6,830,311 B2 | 12-2004 | Fukasawa et al. | 347/29 |
| | C | US-6,631,976 B2 | 10-2003 | Hamamoto et al. | 347/35 |
| | D | US-3,925,788 | 12-1975 | Kashio, Toshio | 347/23 |
| | E | US-6,663,216 | 12-2003 | Kanaya, Munehide | 347/23 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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